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Kind regards,

Team Nexperia



Product data sheet

## 1. Product profile

### 1.1 General description

PNP low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor and NPN Resistor-Equipped Transistor (RET) in a SOT457 (SC-74) small Surface-Mounted Device (SMD) plastic package.

#### 1.2 Features

- Low V<sub>CEsat</sub> (BISS) and resistor-equipped transistor in one package
- Low threshold voltage (<1 V) compared to MOSFET
- Low drive power required
- Space-saving solution
- Reduction of component count

## 1.3 Applications

- Supply line switches
- Battery charger switches
- High-side switches for LEDs, drivers and backlights
- Portable equipment

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
TR1; PNP I	ow V <sub>CEsat</sub> transistor						
$V_{CEO}$	collector-emitter voltage	open base		-	-	-40	V
I <sub>C</sub>	collector current		[1]	-	-	<b>–1</b>	Α
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = -500 \text{ mA};$ $I_B = -50 \text{ mA}$	[2]	-	240	340	$m\Omega$
TR2; NPN r	esistor-equipped transistor						
$V_{CEO}$	collector-emitter voltage	open base		-	-	50	V
Io	output current			-	-	100	mA
R1	bias resistor 1 (input)			7	10	13	kΩ
R2/R1	bias resistor ratio			0.8	1	1.2	

 $<sup>\</sup>begin{tabular}{ll} [1] & Device mounted on a ceramic Printed-Circuit Board (PCB), Al_2O_3, standard footprint. \end{tabular}$ 



<sup>[2]</sup> Pulse test:  $t_p \le 300 \ \mu s$ ;  $\delta \le 0.02$ .

# 2. Pinning information

Table 2. Pinning

Idolo L.	9		
Pin	Description	Simplified outline	Graphic symbol
1	emitter TR1	D- D- D-	
2	base TR1	- 6  - 5  - 4	6 5 4
3	output (collector) TR2	0	
4	GND (emitter) TR2	1 2 3	R1 R2
5	input (base) TR2		TR1
6	collector TR1		
			1 2 3 sym036

# 3. Ordering information

Table 3. Ordering information

Type number	Package	Package		
	Name	Description	Version	
PBLS4003D	SC-74	plastic surface-mounted package (TSOP6); 6 leads	SOT457	

## 4. Marking

Table 4. Marking codes

<u>~</u>	
Type number	Marking code
PBLS4003D	R3

# 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
TR1; PNF	Plow V <sub>CEsat</sub> transistor				
$V_{CBO}$	collector-base voltage	open emitter	-	-40	V
$V_{CEO}$	collector-emitter voltage	open base	-	-40	V
$V_{EBO}$	emitter-base voltage	open collector	-	<b>-</b> 5	V
I <sub>C</sub>	collector current		<u>[1]</u> -	-0.7	Α
			[2] _	-0.85	Α
			[3]	-1	Α
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-2	Α
I <sub>B</sub>	base current		-	-0.3	Α
I <sub>BM</sub>	peak base current	single pulse; $t_p \le 1 \text{ ms}$	-	-1	Α

 Table 5.
 Limiting values ...continued

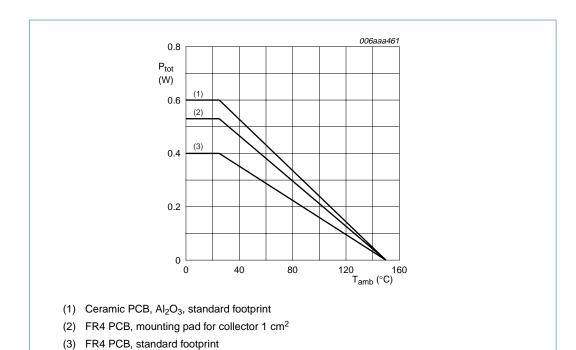
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C	<u>[1]</u> -	250	mW
			[2] _	350	mW
			[3] _	400	mW
TR2; NPI	N resistor-equipped transis	stor			
$V_{CBO}$	collector-base voltage	open emitter	-	50	V
$V_{CEO}$	collector-emitter voltage	open base	-	50	V
$V_{EBO}$	emitter-base voltage	open collector	-	10	V
VI	input voltage				
	positive		-	+40	V
	negative		-	-10	V
I <sub>O</sub>	output current		-	100	mΑ
$I_{CM}$	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	100	mA
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25  ^{\circ}C$	-	200	mW
Per device	ce				
P <sub>tot</sub>	total power dissipation		<u>[1]</u> -	400	mW
			[2] _	530	mW
			[3] _	600	mW
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

<sup>[2]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.

<sup>[3]</sup> Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



### 6. Thermal characteristics

Fig 1.

Table 6. Thermal characteristics

**Power derating curves** 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per device						
R <sub>th(j-a)</sub>	thermal resistance from	in free air	<u>[1]</u> -	-	312	K/W
	junction to ambient		[2] _	-	236	K/W
			<u>[3]</u> _	-	210	K/W
Per TR1; PNP low V <sub>CEsat</sub> transistor						
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	105	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.

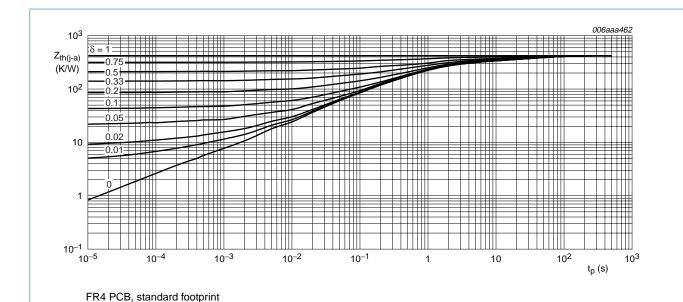


Fig 2. TR1 (PNP): Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

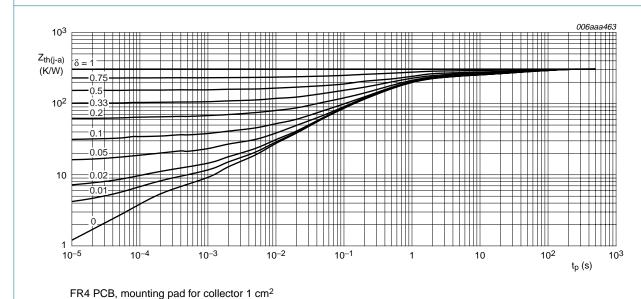
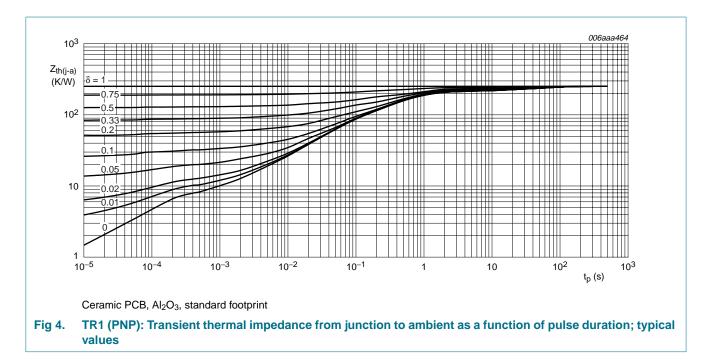


Fig 3. TR1 (PNP): Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



## 7. Characteristics

Table 7. Characteristics

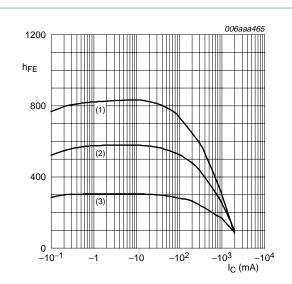
T<sub>amb</sub> = 25 °C unless otherwise specified.

amb - 20	Tamb = 25 O unicos otricimos operinea.						
Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
TR1; PNI	TR1; PNP low V <sub>CEsat</sub> transistor						
$I_{CBO}$	collector-base cut-off	$V_{CB} = -40 \text{ V}; I_E = 0 \text{ A}$	-	-	-0.1	μΑ	
current	$V_{CB} = -40 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 ^{\circ}\text{C}$	-	-	-50	μΑ		
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE} = -30 \text{ V}; V_{BE} = 0 \text{ V}$	-	-	-0.1	μΑ	
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$	-	-	-0.1	μΑ	
h <sub>FE</sub>	DC current gain	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ mA}$	300	-	-		
		$V_{CE} = -5 \text{ V}; I_{C} = -100 \text{ mA}$	<u>[1]</u> 300	-	800		
		$V_{CE} = -5 \text{ V}; I_{C} = -500 \text{ mA}$	<u>[1]</u> 215	-	-		
		$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	<u>[1]</u> 150	-	-		
$V_{\text{CEsat}}$	collector-emitter	$I_C = -100 \text{ mA}; I_B = -1 \text{ mA}$	-	-80	-140	mV	
	saturation voltage	$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	<u>[1]</u> -	-120	-170	mV	
		$I_C = -1 A$ ; $I_B = -100 \text{ mA}$	<u>[1]</u> -	-220	-310	mV	
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	[1] _	240	340	mΩ	
$V_{BEsat}$	base-emitter saturation voltage	$I_C = -1 A$ ; $I_B = -50 \text{ mA}$	[1] -	-	-1.1	V	
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	[1] _	-	-1	V	

**Table 7.** Characteristics ...continued  $T_{amb} = 25 \,^{\circ}\text{C}$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
f <sub>T</sub>	transition frequency	$I_C = -50 \text{ mA}; V_{CE} = -10 \text{ V};$ f = 100 MHz	150	-	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = I_e = 0 \text{ A};$ f = 1 MHz	-	-	12	pF
TR2; NPI	N resistor-equipped tra	ansistor				
I <sub>CBO</sub>	collector-base cut-off current	$V_{CB} = 50 \text{ V}; I_E = 0 \text{ A}$	-	-	100	nA
I <sub>CEO</sub>	collector-emitter	$V_{CE} = 30 \text{ V}; I_{B} = 0 \text{ A}$	-	-	1	μΑ
	cut-off current	$V_{CE} = 30 \text{ V}; I_{B} = 0 \text{ A};$ $T_{j} = 150 ^{\circ}\text{C}$	-	-	50	μΑ
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$	-	-	400	μΑ
h <sub>FE</sub>	DC current gain	$V_{CE} = 5 \text{ V}; I_{C} = 5 \text{ mA}$	30	-	-	
V <sub>CEsat</sub>	collector-emitter saturation voltage	$I_C = 10 \text{ mA}; I_B = 0.5 \text{ mA}$	-	-	150	mV
$V_{I(off)}$	off-state input voltage	$V_{CE} = 5 \text{ V}; I_{C} = 100 \mu\text{A}$	-	1.1	8.0	V
$V_{I(on)}$	on-state input voltage	$V_{CE} = 0.3 \text{ V}; I_{C} = 10 \text{ mA}$	2.5	1.8	-	V
R1	bias resistor 1 (input)		7	10	13	$k\Omega$
R2/R1	bias resistor ratio		8.0	1	1.2	
C <sub>c</sub>	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-	-	2.5	pF

<sup>[1]</sup> Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 



$$V_{CE} = -5 \text{ V}$$

- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \,^{\circ}C$

Fig 5. TR1 (PNP): DC current gain as a function of collector current; typical values

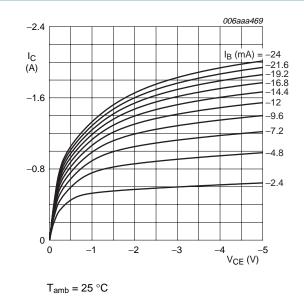
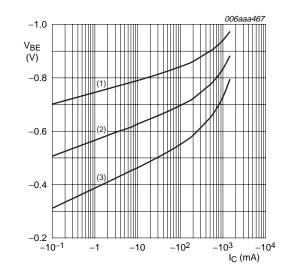


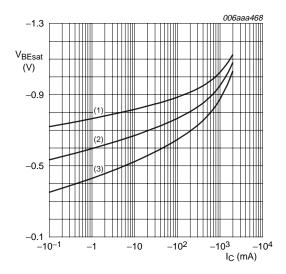
Fig 6. TR1 (PNP): Collector current as a function of collector-emitter voltage; typical values





- (1)  $T_{amb} = -55 \,^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

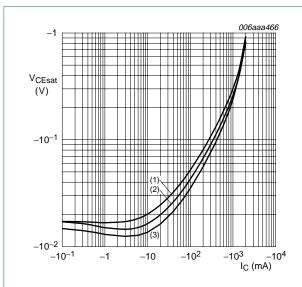
Fig 7. TR1 (PNP): Base-emitter voltage as a function of collector current; typical values



$$I_{\rm C}/I_{\rm B} = 20$$

- (1)  $T_{amb} = -55 \,^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

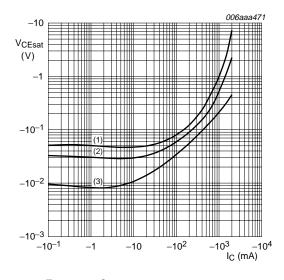
Fig 8. TR1 (PNP): Base-emitter saturation voltage as a function of collector current; typical values



$$I_C/I_B = 20$$

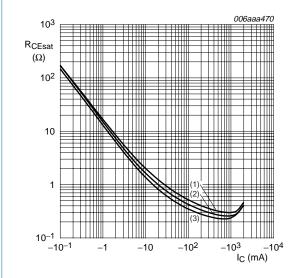
- (1) T<sub>amb</sub> = 100 °C
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

Fig 9. TR1 (PNP): Collector-emitter saturation voltage as a function of collector current; typical values



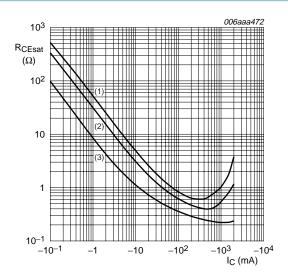
- (1)  $I_C/I_B = 100$
- (2)  $I_C/I_B = 50$
- (3)  $I_C/I_B = 10$

Fig 10. TR1 (PNP): Collector-emitter saturation voltage as a function of collector current; typical values



- $I_{\rm C}/I_{\rm B}=20$
- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

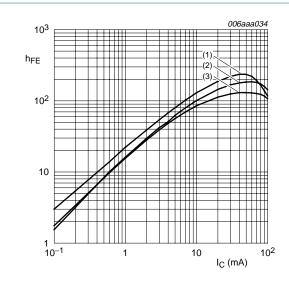
Fig 11. TR1 (PNP): Collector-emitter saturation resistance as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

- (1)  $I_C/I_B = 100$
- (2)  $I_C/I_B = 50$
- (3)  $I_C/I_B = 10$

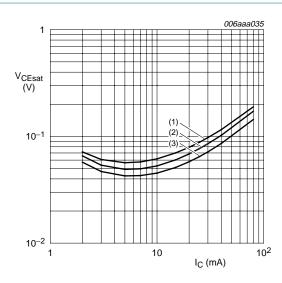
Fig 12. TR1 (PNP): Collector-emitter saturation resistance as a function of collector current; typical values



$$V_{CE} = 5 V$$

- (1)  $T_{amb} = 150 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -40 \, ^{\circ}C$

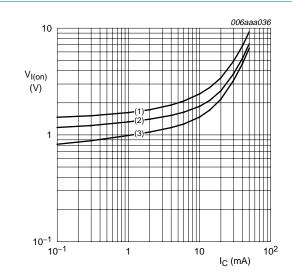
Fig 13. TR2 (NPN): DC current gain as a function of collector current; typical values



$$I_{\rm C}/I_{\rm B} = 20$$

- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -40 \, ^{\circ}C$

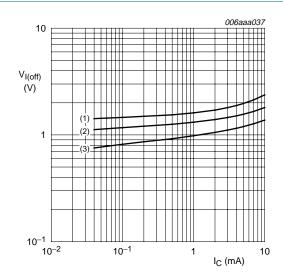
Fig 14. TR2 (NPN): Collector-emitter saturation voltage as a function of collector current; typical values





- (1)  $T_{amb} = -40 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3) T<sub>amb</sub> = 100 °C

Fig 15. TR2 (NPN): On-state input voltage as a function of collector current; typical values

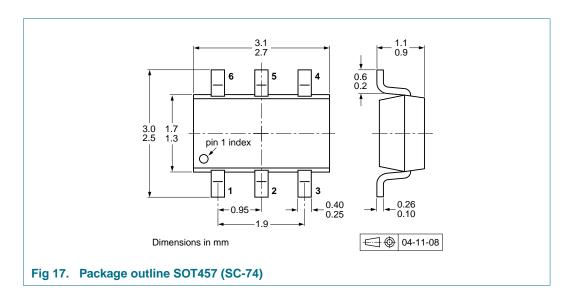


$$V_{CE} = 5 V$$

- (1)  $T_{amb} = -40 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 16. TR2 (NPN): Off-state input voltage as a function of collector current; typical values

# 8. Package outline



# 9. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	e Description Packing		g quantity	
				3000	10000
PBLS4003D	SOT457	4 mm pitch, 8 mm tape and reel; T1	[2]	-115	-135
		4 mm pitch, 8 mm tape and reel; T2	[3]	-125	-165

[1] For further information and the availability of packing methods, see  $\underline{\text{Section 13}}$ .

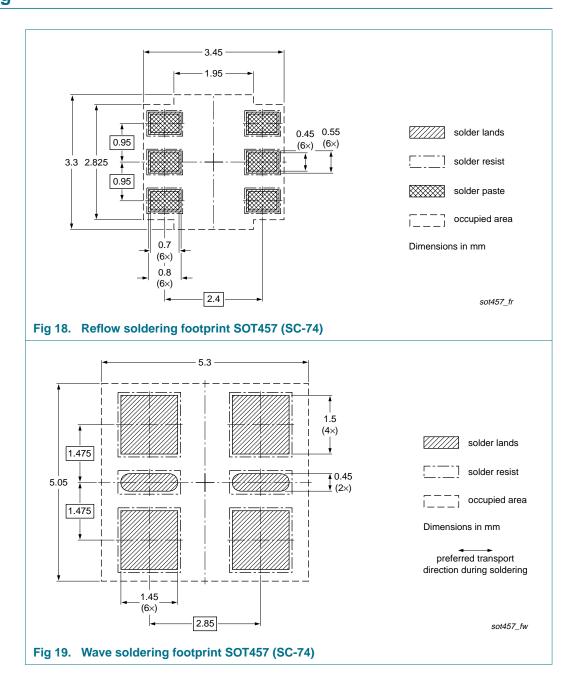
[2] T1: normal taping

[3] T2: reverse taping

**PBLS4003D** 

40 V PNP BISS loadswitch

# 10. Soldering





# 11. Revision history

### Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
PBLS4003D_3	20090105	Product data sheet	-	PBLS4003D_2	
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>				
	<ul> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>				
	• <u>Figure 5</u> , <u>9</u> a	and 10: amended			
<ul> <li>Section 12 "Legal information": updated</li> </ul>					
PBLS4003D_2	20050704	Product data sheet	-	PBLS4003D_1	
PBLS4003D_1	20041201	Objective data sheet	-	-	

## 12. Legal information

#### 12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.



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Other Similar products are found below:

RN1607(TE85L,F) DTC113EET1G DTC144ECA-TP DTC144VUAT106 MUN5241T1G BCR158WH6327XTSA1 NSBA114TDP6T5G
NSBA143ZF3T5G NSBC114YF3T5G NSBC123TF3T5G SMUN5235T1G SMUN5330DW1T1G SSVMUN5312DW1T2G
RN1303(TE85L,F) RN4605(TE85L,F) TTEPROTOTYPE79 DDTC114EUAQ-7-F EMH15T2R SMUN2214T3G SMUN5335DW1T1G
NSBC114TF3T5G NSBC143ZPDP6T5G NSVMUN5113DW1T3G SMUN5230DW1T1G SMUN5133T1G SMUN2214T1G DTC114EUATP NSBA144EF3T5G NSVDTA114EET1G 2SC2223-T1B-A 2SC3912-TB-E SMUN5237DW1T1G SMUN5213DW1T1G
SMUN5114DW1T1G SMUN2111T1G NSVDTC144EM3T5G DTC124ECA-TP DTC123TM3T5G DTA114ECA-TP DTA113EM3T5G
DCX115EK-7-F DTC113EM3T5G NSVMUN5135DW1T1G NSVMUN2237T1G SMUN5335DW1T2G SMUN5216DW1T1G
NSVMUN5316DW1T1G NSVMUN5312DW1T2G NSVMUN5215DW1T1G NSVMUN5213DW1T3G